

H11AA1

H11AA3

H11AA2

H11AA4

## DESCRIPTION

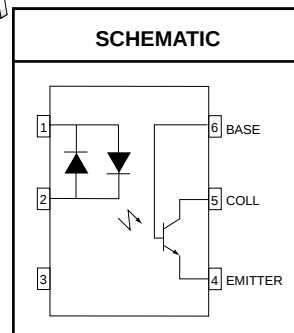
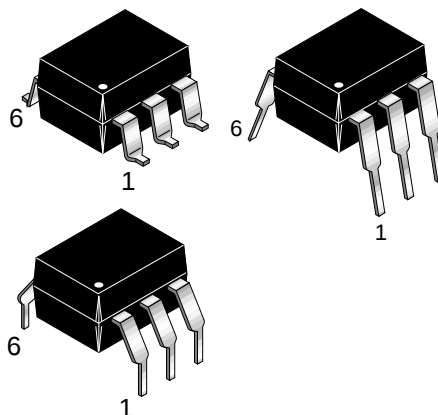
The H11AAX series consists of two gallium-arsenide infrared emitting diodes connected in inverse parallel driving a single silicon phototransistor output.

## FEATURES

- Bi-polar emitter input
- Built-in reverse polarity input protection
- Underwriters Laboratory (UL) recognized — File #E90700
- VDE approved — File #E94766 (ordering option '300')

## APPLICATIONS

- AC line monitor
- Unknown polarity DC sensor
- Telephone line interface



| Parameter                                                   | Symbol              | Device | Value          | Units |
|-------------------------------------------------------------|---------------------|--------|----------------|-------|
| TOTAL DEVICE                                                |                     |        |                |       |
| Storage Temperature                                         | T <sub>STG</sub>    | All    | -55 to +150    | °C    |
| Operating Temperature                                       | T <sub>OPR</sub>    | All    | -55 to +100    | °C    |
| Lead Solder Temperature                                     | T <sub>SOL</sub>    | All    | 260 for 10 sec | °C    |
| Total Device Power Dissipation<br>Derate Linearly From 25°C | P <sub>D</sub>      | All    | 350            | mW    |
|                                                             |                     |        | 4.6            | mW/°C |
| EMITTER                                                     |                     |        |                |       |
| Continuous Forward Current                                  | I <sub>F</sub>      | All    | 100            | mA    |
| Forward Current - Peak (1 μs pulse, 300 pps)                | I <sub>F</sub> (pk) | All    | ±1.0           | A     |
| LED Power Dissipation<br>Derate Linearly From 25°C          | P <sub>D</sub>      | All    | 200            | mW    |
|                                                             |                     |        | 2.6            | mW/°C |
| DETECTOR                                                    |                     |        |                |       |
| Detector Power Dissipation<br>Derate above 25°C             | P <sub>D</sub>      | All    | 300            | mW    |
|                                                             |                     |        | 4.0            | mW/°C |

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**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  Unless otherwise specified.)

**INDIVIDUAL COMPONENT CHARACTERISTICS**

| Parameter                                 | Test Conditions                            | Symbol     | Device               | Min | Typ | Max       | Unit |
|-------------------------------------------|--------------------------------------------|------------|----------------------|-----|-----|-----------|------|
| <b>EMITTER</b>                            |                                            |            |                      |     |     |           |      |
| Input Forward Voltage                     | $I_F = \pm 10\text{ mA}$                   | $V_F$      | All                  |     | 1.2 | 1.5       | V    |
| Capacitance                               | $V_F = 0\text{ V}$ , $f = 1.0\text{ MHz}$  | $C_J$      | All                  |     | 80  |           | pF   |
| <b>DETECTOR</b>                           |                                            |            |                      |     |     |           |      |
| Breakdown Voltage<br>Collector to Emitter | $I_C = 1.0\text{ mA}$ , $I_F = 0$          | $BV_{CEO}$ | All                  | 30  |     |           | V    |
| Collector to Base                         | $I_C = 100\text{ }\mu\text{A}$ , $I_F = 0$ | $BV_{CBO}$ | All                  | 70  |     |           | V    |
| Emitter to Base                           | $I_E = 100\text{ }\mu\text{A}$ , $I_F = 0$ | $BV_{EBO}$ | All                  | 5   |     |           | V    |
| Emitter to Collector                      | $I_E = 100\text{ }\mu\text{A}$ , $I_F = 0$ | $BV_{ECO}$ | All                  | 7   |     |           | V    |
| Leakage Current<br>Collector to Emitter   | $V_{CE} = 10\text{ V}$ , $I_F = 0$         | $I_{CEO}$  | H11AA1,3,4<br>H11AA2 |     |     | 50<br>200 | nA   |
| Capacitance<br>Collector to Emitter       | $V_{CE} = 0$ , $f = 1\text{ MHz}$          | $C_{CE}$   | All                  |     | 10  |           | pF   |
| Collector to Base                         | $V_{CE} = 0$ , $f = 1\text{ MHz}$          | $C_{CB}$   | All                  |     | 80  |           | pF   |
| Emitter to Base                           | $V_{CE} = 0$ , $f = 1\text{ MHz}$          | $C_{EB}$   | All                  |     | 15  |           | pF   |

**TRANSFER CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  Unless otherwise specified.)

| Characteristics                                 | Test Conditions                                              | Symbol        | Device | Min | Typ | Max | Units |
|-------------------------------------------------|--------------------------------------------------------------|---------------|--------|-----|-----|-----|-------|
| Current Transfer Ratio,<br>Collector to Emitter | $I_F = \pm 10\text{ mA}$ , $V_{CE} = 10\text{ V}$            | $CTR_{CE}$    | H11AA4 | 100 |     |     | %     |
|                                                 |                                                              |               | H11AA3 | 50  |     |     |       |
|                                                 |                                                              |               | H11AA1 | 20  |     |     |       |
|                                                 |                                                              |               | H11AA2 | 10  |     |     |       |
| Current Transfer Ratio, Symmetry                | $I_F = \pm 10\text{ mA}$ , $V_{CE} = 10\text{ V}$ (Figure.8) |               | All    | .33 |     | 3.0 | %     |
| Saturation Voltage<br>Collector to Emitter      | $I_F = \pm 10\text{ mA}$ , $I_{CE} = 0.5\text{ mA}$          | $V_{CE(SAT)}$ | All    |     |     | .40 | V     |

**ISOLATION CHARACTERISTICS**

| Characteristic                   | Test Conditions                          | Symbol    | Min       | Typ | Max | Units    |
|----------------------------------|------------------------------------------|-----------|-----------|-----|-----|----------|
| Package Capacitance input/output | $V_{I-O} = 0$ , $f = 1\text{ MHz}$       | $C_{I-O}$ |           | 0.7 |     | pF       |
| Isolation Voltage                | $f = 60\text{ Hz}$ , $t = 1\text{ min.}$ | $V_{ISO}$ | 5300      |     |     | V        |
| Isolation Resistance             | $V_{I-O} = 500\text{ VDC}$               | $R_{ISO}$ | $10^{11}$ |     |     | $\Omega$ |

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Fig. 1 Input Voltage vs. Input Current

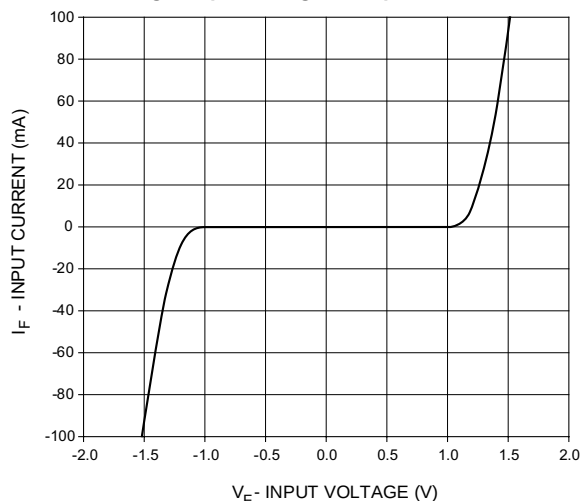


Fig. 2 Normalized CTR vs. Forward Current

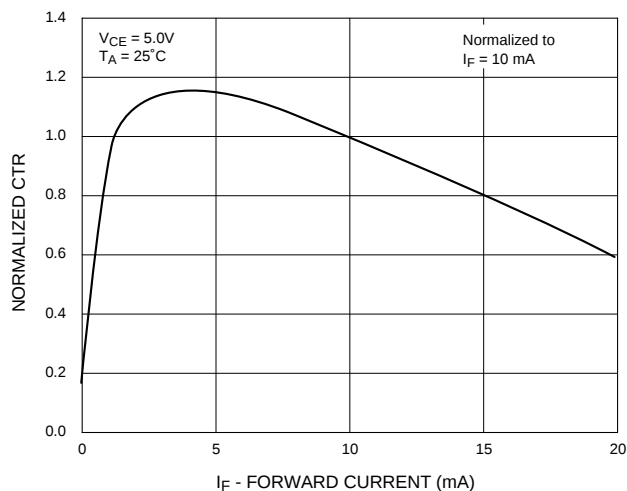


Fig. 3 Normalized CTR vs. Ambient Temperature

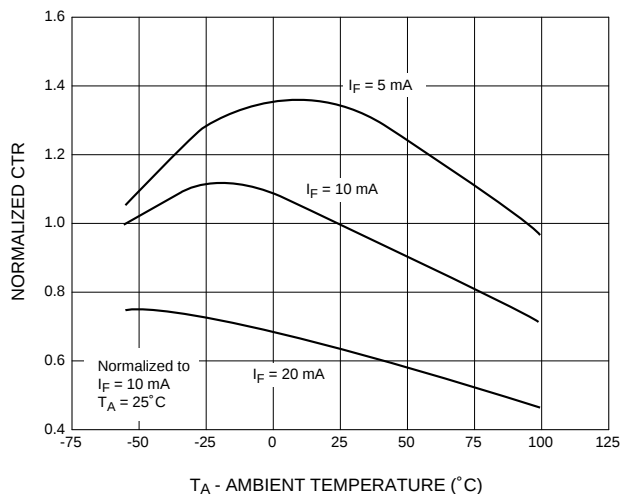


Fig. 4 CTR vs. R<sub>BE</sub> (Unsaturated)

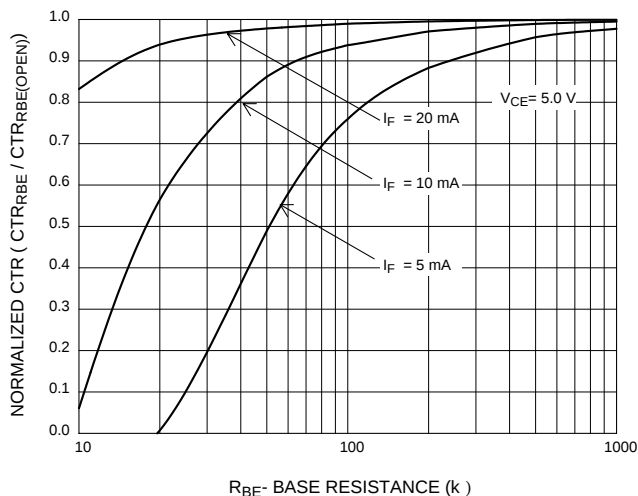


Fig. 5 CTR vs. R<sub>BE</sub> (Saturated)

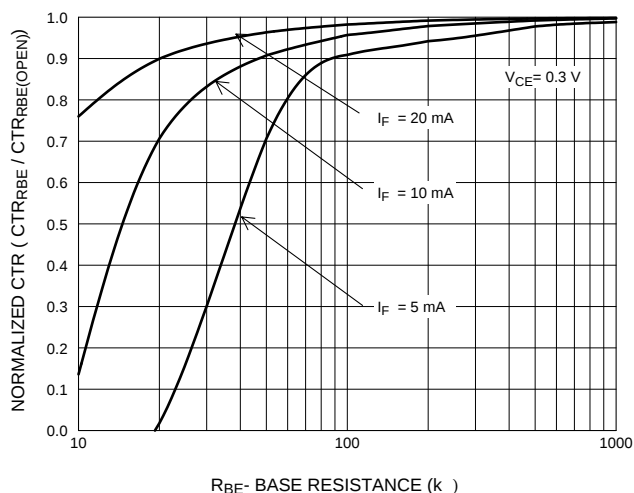
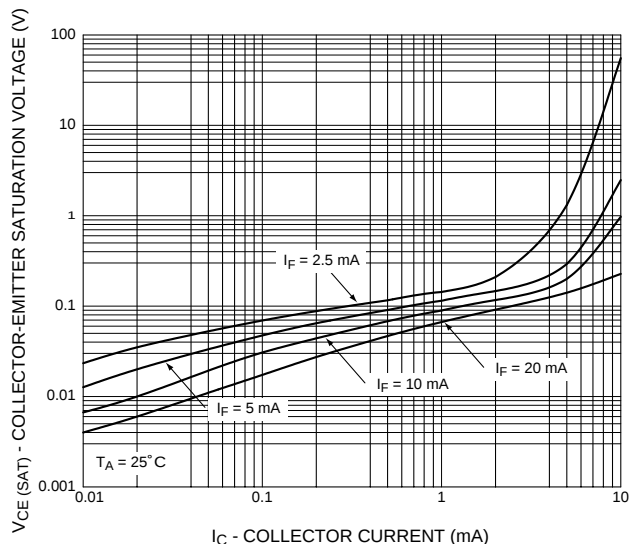


Fig. 6 Collector-Emitter Saturation Voltage vs. Collector Current



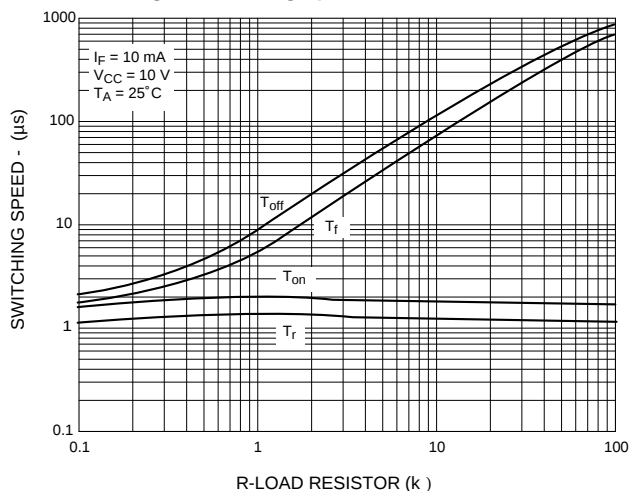
H11AA1

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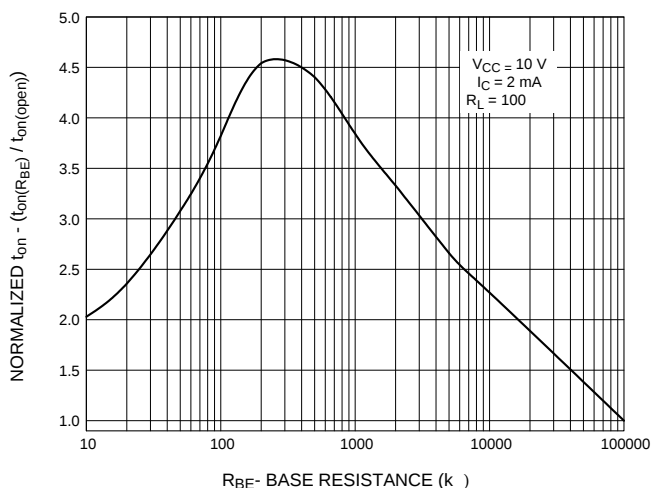
H11AA2

H11AA4

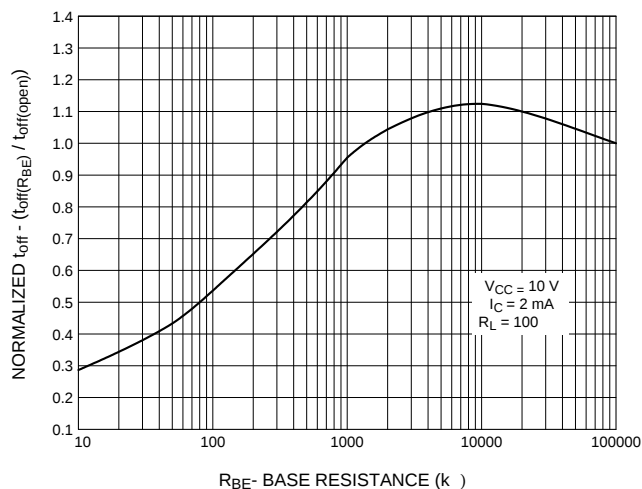
**Fig. 7 Switching Speed vs. Load Resistor**



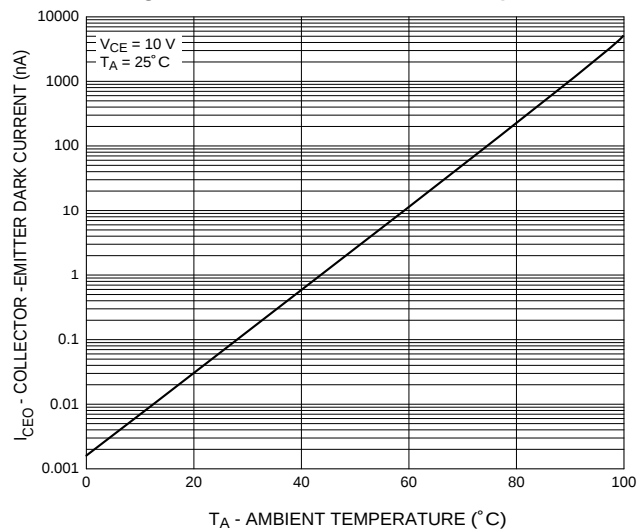
**Fig. 8 Normalized  $t_{on}$  vs.  $R_{BE}$**



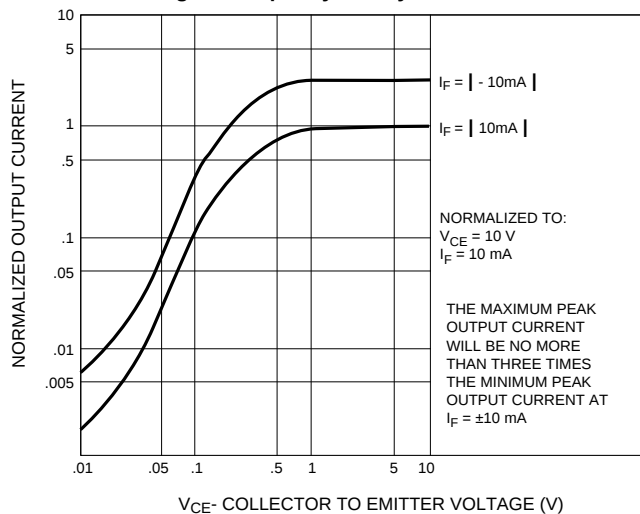
**Fig. 9 Normalized  $t_{off}$  vs.  $R_{BE}$**



**Fig. 10 Dark Current vs. Ambient Temperature**



**Fig. 11 Output Symmetry Characteristics**



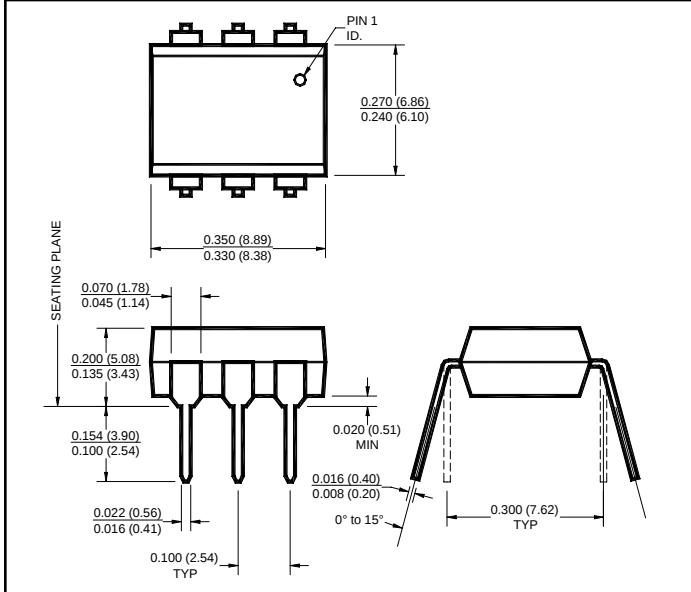
H11AA1

H11AA3

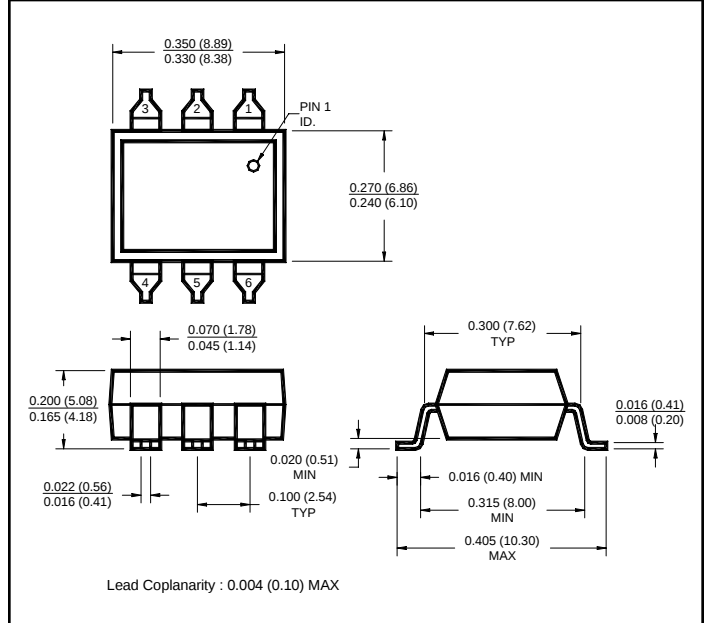
H11AA2

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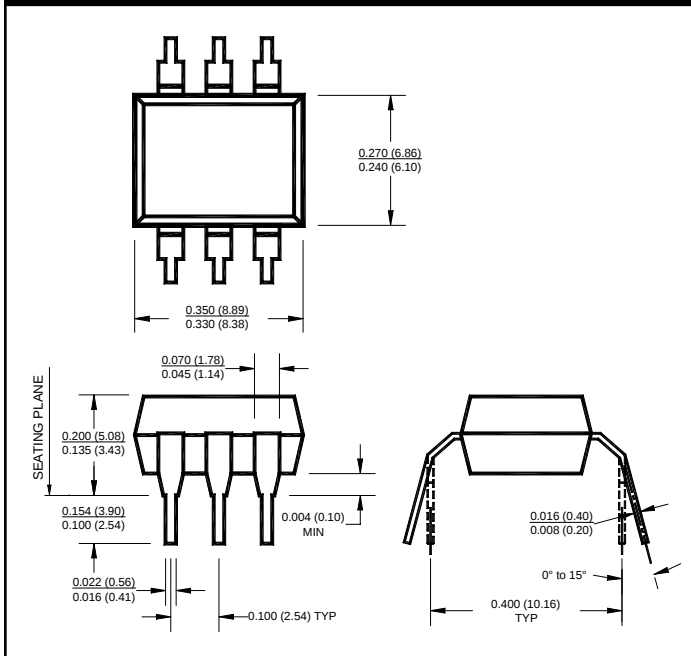
## Package Dimensions (Through Hole)



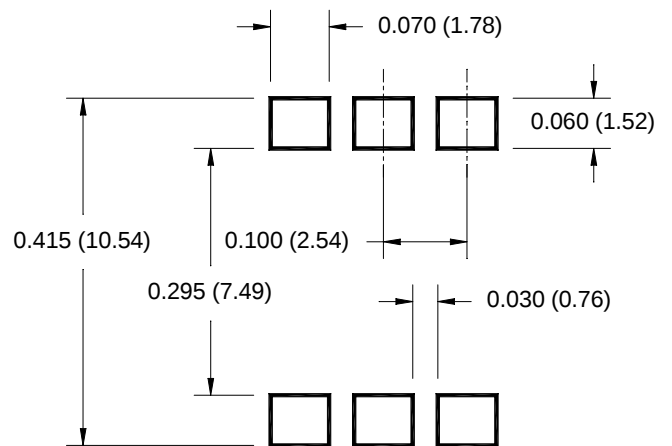
## Package Dimensions (Surface Mount)



## Package Dimensions (0.4" Lead Spacing)



## Recommended Pad Layout for Surface Mount Leadform



### NOTE

All dimensions are in inches (millimeters)

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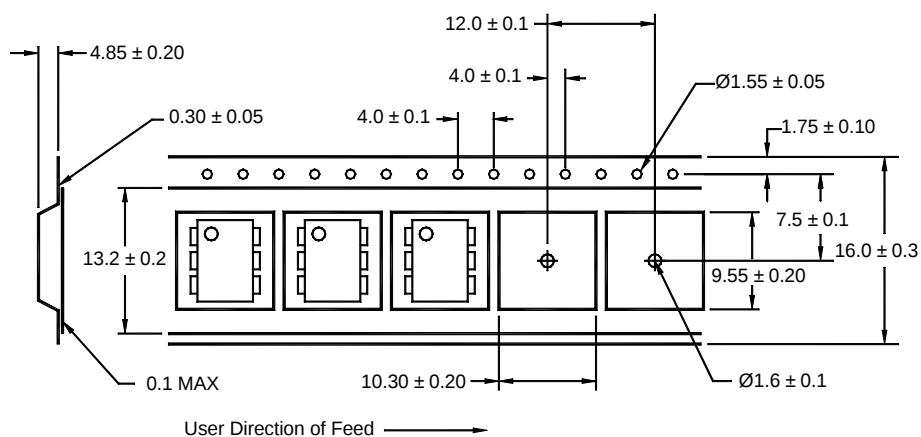
H11AA2

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## ORDERING INFORMATION

| Option | Order Entry Identifier | Description                            |
|--------|------------------------|----------------------------------------|
| S      | .S                     | Surface Mount Lead Bend                |
| SD     | .SD                    | Surface Mount; Tape and Reel           |
| W      | .W                     | 0.4" Lead Spacing                      |
| 300    | .300                   | VDE 0884                               |
| 300W   | .300W                  | VDE 0884, 0.4" Lead Spacing            |
| 3S     | .3S                    | VDE 0884, Surface Mount                |
| 3SD    | .3SD                   | VDE 0884, Surface Mount, Tape and Reel |

## Carrier Tape Specifications ("D" Taping Orientation)



## NOTE

All dimensions are millimeters

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